

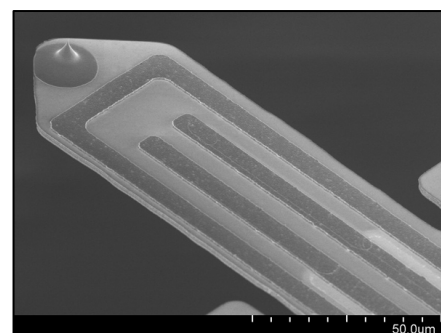
# PRSA-L100-F400-Si-PCB

Silicon piezo-resistive sensing cantilevers

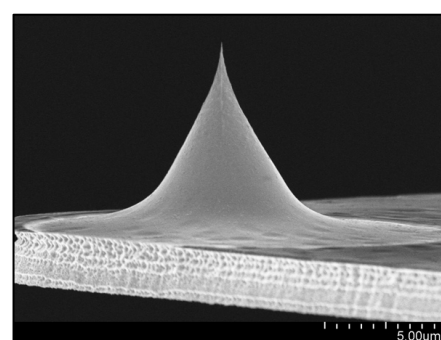


## General description

Piezo-Resistive Sensing Active (PRSA) probes are silicon cantilevers with an integrated piezo-resistor and a heater for self-sensing and self-actuating scanning probe microscopy applications. The piezo-resistors are integrated into a matched Wheatstone bridge to raise the sensitivity and compensate environmental thermal drift. By using the self-sensing readout no laser adjustment is necessary in comparison to conventional optical readout AFM systems. This saves time during a cantilever change. The free space above the cantilever enables new applications and combination of AFM with various instruments. The cantilever chip is bonded to a small printed circuit board (PCB) with a small connector for a quick cantilever change. The counter part PCB for the cantilever PCB can be connected to a low-noise pre-amplifier with a flat flex cable.



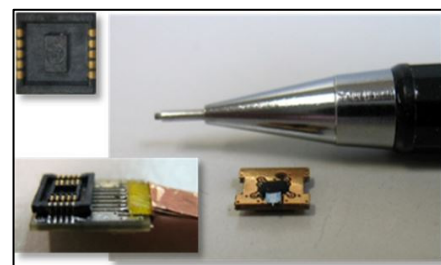
Tip side of a PRSA-L100 cantilever with Al tracks for reading out the deflection signal



Side view of a PRSA-L100-F400 cantilever

## Specifications

Model	PRSA-L100-F400-Si-PCB
Tip radius (apex)	<15 nm
Tip height	4...6 $\mu\text{m}$
Tip material	silicon
Resonant frequency	250..550 kHz
Spring constant	14...170 N/m
Recomm. AFM mode	non-contact
sensitivity*	1...3 $\mu\text{V}/\text{nm}$
force sensitivity*	4...170 nN/ $\mu\text{V}$
Length, width	110 $\pm$ 5 $\mu\text{m}$ , 48 $\pm$ 2 $\mu\text{m}$
Material	silicon cantilever, boron doped 1k Ohm piezo resistors, aluminium tracks
Deflection sensing	on chip piezo-resistive bridge
Actuator	external shaker or on chip heater (12 +/-1 Ohm)
Electrical connections	bonded to small PCB with connector (counter part PCB available) or optional bonding pads on chip
Chip dimensions (h, w, l)	0.3 / 1.0 / 2.7 mm
* not amplified, 2.048 V bridge supply	

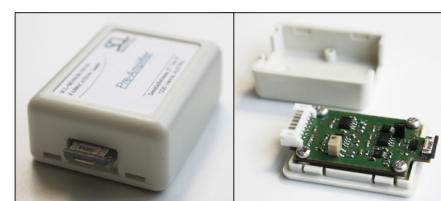


Cantilever is bonded to a 6 x 4.5 mm PCB (height with connector 1.6 mm, with CP-PCB: 2.5 mm); left: counter part PCB

## Applications:

- Integration on a standard AFM scanner and high-speed AFM
- Force or deflection measurements within TEM, SEM, XPS, etc.

**What about your application? Contact us!**



Hardware for amplified readout: Low-noise pre-amplifier (45x35 mm)

**SCL-Sensor.Tech. Fabrication GmbH**

Seestadtstrasse 27, Top 27

1220 Vienna, AUSTRIA

web: [www.sclsensortech.com](http://www.sclsensortech.com)

Contact: Alexander Deutschinger

Phone: +43-1-8904345-14

[a.deutschinger@scsensortech.com](mailto:a.deutschinger@scsensortech.com)

Leaflet version: 2018-07-05